

Central Sophisticated Instrumentation Facility (CSIF)

Birla Institute of Technology & Science, Pilani, K K Birla Goa Campus

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(Raman Spectrometer)

Model: LabRam HR Horiba France

Department:											
						lave sa	ampling modalities	SAMF s and requirements disc	PLE INFORMATION ussed with the techni	cal in-charge (Y/N	······································
						S. No.	Sample code* (UIN – X*)	Name of the Experiment spectra/PL/ Mapping	Laser Line(325/ 532/ 633/ 785 nm)	Expected peak Range	Mode of techniqu (Low and high temperature)
andling	•	not present any danger to safety to the operator before		•							
We sha	•	ie CSIF, BITS PILANI, K i sewhere.	K Birla Goa Campus v	vhile publishing/re	porting the results						
S.No	o. Nature	of Analysis*	Rate	Number of samples	Total						
	'	<u> </u>	1	Total							
'aymer	nt Details:										
ource	of funding & Deta	ils:									
otal Aı	mount Paid to BITS	S BioCyTiH Foundation: R	Rs/-	Date:/							
User with date		HOD/Supervisor/	PI Technica	ıl In-charge	Accounts Office						